

XATOM: an integrated toolkit for X-ray and atomic physics

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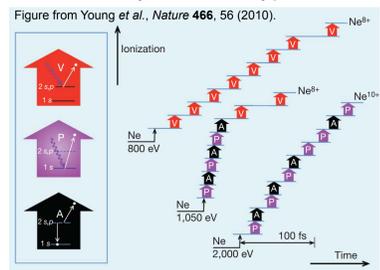
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Introduction

X-ray free-electron lasers (XFEL) open a new era in science and technology, offering many unique opportunities that have not been conceivable with conventional light sources. Because XFELs produce ultrashort pulses with a very high X-ray photon fluence, materials interacting with XFEL pulses undergo significant radiation damage and possibly become highly ionized. To understand the underlying physics, it is crucial to describe detailed ionization and relaxation dynamics in individual atoms during XFEL pulses. Here we present an integrated toolkit to investigate X-ray-induced atomic processes and to simulate electronic damage dynamics. This XATOM toolkit can handle all possible electronic configurations of all atom/ion species, and calculate physical observables during/after intense X-ray pulses. By use of XATOM, we can explore many exciting XFEL-related phenomena from multiphoton multiple ionization to molecular imaging and warm dense matter formation.

Diagrams of multiphoton absorption mechanisms in Ne induced by ultraintense X-ray pulses



Theoretical and numerical details

Hamiltonian and perturbation theory
To treat X-ray-atom interactions, we employ a consistent *ab initio* framework based on nonrelativistic quantum electrodynamics and perturbation theory. For implementation, we use the Hartree-Fock-Slater model with the Latter tail correction.

$$\hat{H} = \hat{H}_{mol} + \hat{H}_{EM} + \hat{H}_{int}$$

$$\hat{H}_{EM} = \sum_{\mathbf{k}, \lambda} \omega_{\mathbf{k}} \hat{a}_{\mathbf{k}, \lambda}^\dagger \hat{a}_{\mathbf{k}, \lambda}, \quad \omega_{\mathbf{k}} = |\mathbf{k}|/\alpha$$

$$\hat{H}_{int} = \alpha \int d^3x \hat{\psi}^\dagger(\mathbf{x}) \left[\hat{\mathbf{A}}(\mathbf{x}) \cdot \frac{\nabla}{i} \right] \hat{\psi}(\mathbf{x}) + \frac{\alpha^2}{2} \int d^3x \hat{\psi}^\dagger(\mathbf{x}) \hat{A}^2(\mathbf{x}) \hat{\psi}(\mathbf{x})$$

$|I\rangle$: initial state, $|F\rangle$: final state

$$\Gamma_{FI} = 2\pi\delta(E_F - E_I) \left| \langle F | \hat{H}_{int} | I \rangle + \sum_M \frac{\langle F | \hat{H}_{int} | M \rangle \langle M | \hat{H}_{int} | I \rangle}{E_I - E_M + i\epsilon} + \dots \right|^2$$

Rate equation model

To simulate electronic dynamics during intense X-ray pulses, we employ the rate equation approach with all computed cross sections and rates for all possible *n*-hole configurations, and calculate charge state distribution, electron/fluorescence spectra, scattering signals, etc.

$$\frac{d}{dt} P_I(t) = \sum_{I' \neq I}^{\text{all config.}} [\Gamma_{I' \rightarrow I} P_{I'}(t) - \Gamma_{I \rightarrow I'} P_I(t)]$$

P Photoabsorption $|I\rangle = |\Psi_0^{N_{EM}}\rangle |N_{EM}\rangle$, $|F\rangle = |\Psi_F^{N_{EM}}\rangle |N_{EM}-1\rangle$

$$\sigma_P(i, \omega) = \frac{4}{3} \pi^2 \omega N_i \sum_{l_j=|i-1|}^{i+1} \frac{l_j}{2l_j+1} \left| \int_0^\infty P_{n_i, l_j}(r) P_{i, l_j}(r) r dr \right|^2$$

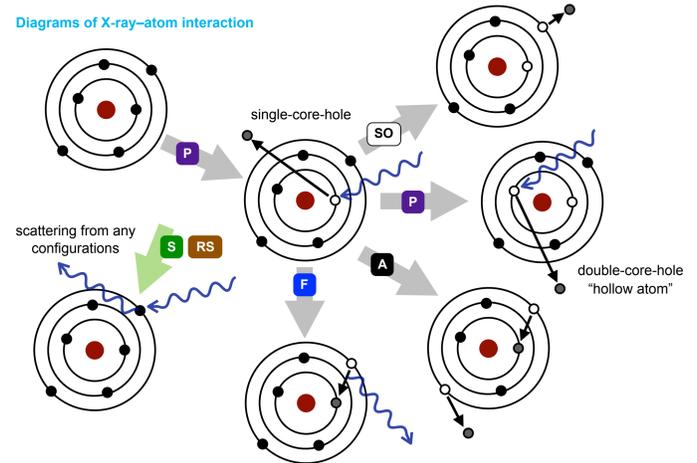
F Fluorescence $|I\rangle = \hat{c}_i |\Phi_0^{N_{EM}}\rangle |0\rangle$, $|F\rangle = \hat{c}_i' |\Phi_0^{N_{EM}}\rangle |1\rangle$

$$\Gamma_F(i, j) = \frac{4}{3} \pi^2 \omega^3 (I_i - I_j) \sum_{l_j=|i-1|}^{i+1} \frac{l_j}{2l_j+1} \left| \int_0^\infty P_{n_i, l_j}(r) P_{n_j, l_j}(r) r dr \right|^2$$

A Auger / Coster-Kronig decay $|I\rangle = \hat{c}_i |\Phi_0^{N_{EM}}\rangle$, $|F\rangle = \hat{c}_i' \hat{c}_j |\Phi_0^{N_{EM}}\rangle$

$$\Gamma_A(i, j, j') = \pi \frac{N_i^H N_{j'}^H}{2l_i+1} \sum_{L=|l_i-l_{j'}|}^{l_i+l_{j'}} \sum_{S=0}^1 (2L+1)(2S+1) |M_{LS}(j, j', i, i')|^2$$

Diagrams of X-ray-atom interaction



SO Shake-off process: sudden approximation

$$p_{SO}(i; I, I') = 1 - \left| \int_0^\infty P_{n_i, l_i}(r; I) P_{n_i, l_i}(r; I') r dr \right|^2$$

S Elastic X-ray scattering $|I\rangle = |\Psi_0^{N_{EM}}\rangle |N_{EM}\rangle$

$$|F\rangle = |\Psi_0^{N_{EM}}\rangle \hat{a}_{\mathbf{k}, \lambda, \lambda'} |N_{EM}-1\rangle$$

$$f^0(\mathbf{Q}) = \int \rho(\mathbf{r}) e^{i\mathbf{Q}\cdot\mathbf{r}} d^3r$$

$$\frac{d\sigma_S}{d\Omega}(t) = \sum_I P_I(t) \left(\frac{d\sigma_S}{d\Omega} \right)_I = \left(\frac{d\sigma}{d\Omega} \right)_T \sum_I P_I(t) |f_I^0(\mathbf{Q})|^2$$

RS Resonant elastic X-ray scattering (dispersion correction)

$$f(\mathbf{Q}, \omega) = f^0(\mathbf{Q}) + f'(\omega) + i f''(\omega)$$

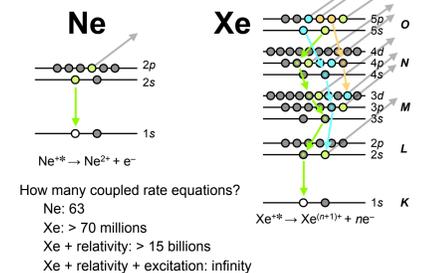
$$f'(\omega) = -\frac{1}{2\pi^2\alpha} \mathcal{P} \int_0^\infty \frac{\omega'^2}{\omega'^2 - \omega^2} \sigma_P(\omega') d\omega'$$

$$f''(\omega) = -\frac{\omega}{4\pi\alpha} \sigma_P(\omega)$$

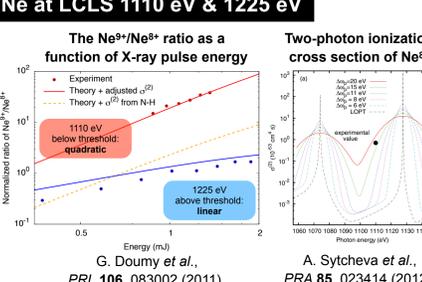
atom

fundamental interaction between atoms and XFEL pulses

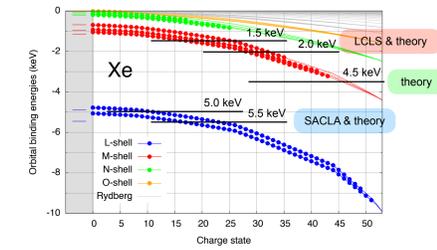
Decay complexity for light and heavy atoms



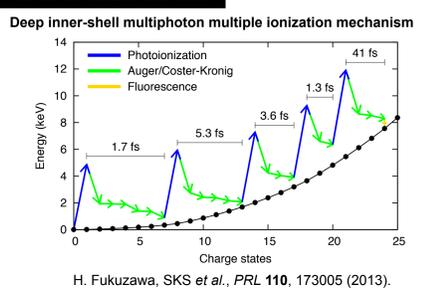
Ne at LCLS 1110 eV & 1225 eV



Ionization potentials of Xe as a function of charge states



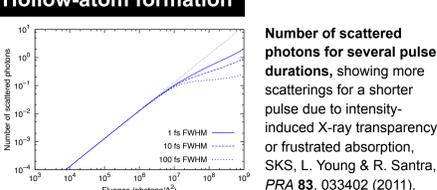
Xe at SACLA 5.5 keV



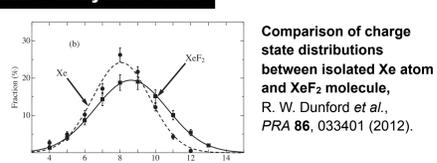
molecule

imaging from small molecules to biological macromolecules

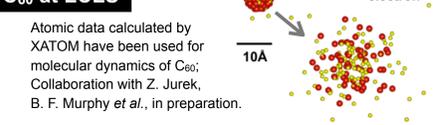
Hollow-atom formation



XeF2 at synchrotron



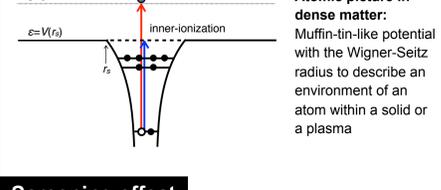
C60 at LCLS



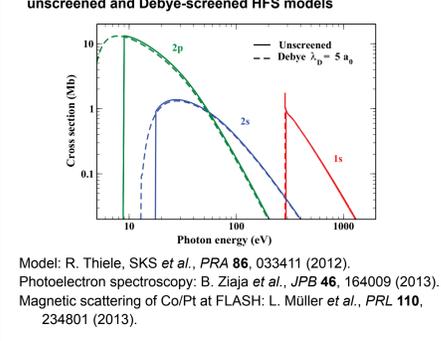
solid

electronic structure in extreme conditions

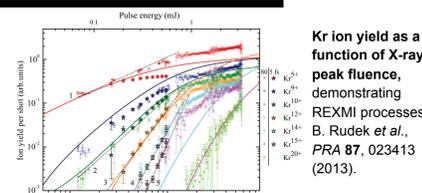
Screening effect



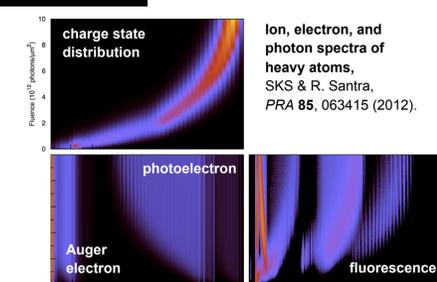
Photoabsorption cross sections for C calculated with the unscreened and Debye-screened HFS models



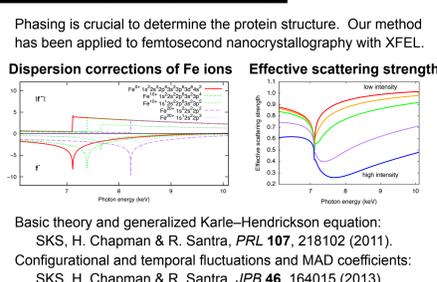
Kr at LCLS 1.5 keV & 2 keV



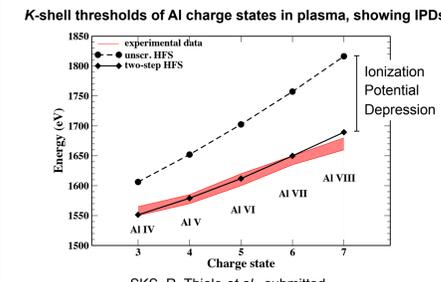
Xe at 4.5 keV



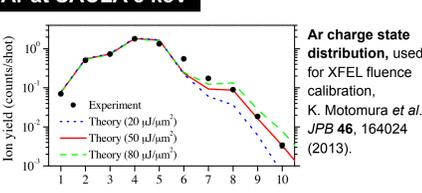
MAD at high x-ray intensity



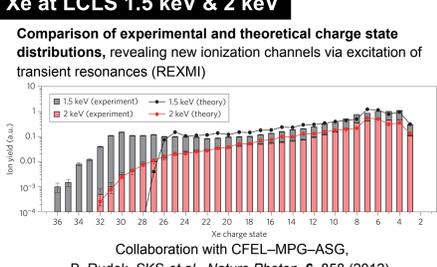
Al plasma at LCLS



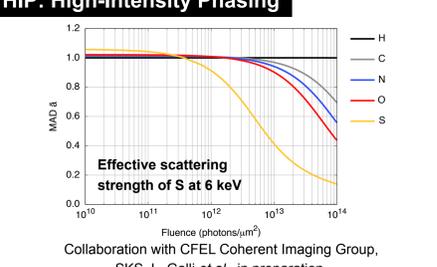
Ar at SACLA 5 keV



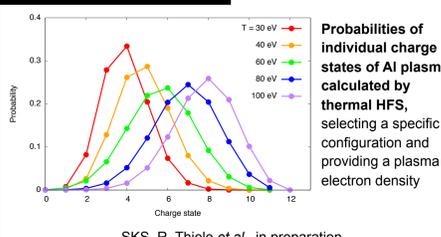
Xe at LCLS 1.5 keV & 2 keV



HIP: High-Intensity Phasing



Two-step HFS model



HHG of rare gases

